Decade Counter

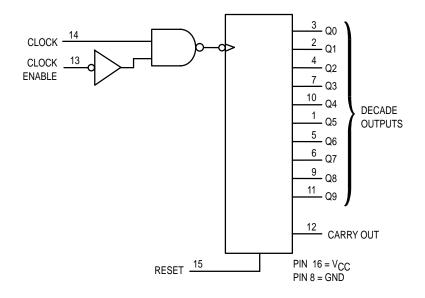
High-Performance Silicon-Gate CMOS

The MC74HC4017 is identical in pinout to the standard CMOS MC14017B. The device inputs are compatible with standard CMOS outputs; with pullup resistors, they are compatible with LSTTL outputs.

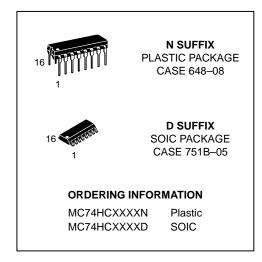
The HC4017 uses a five stage Johnson counter and decoding logic to provide high–speed operation. This device also has an active–high, as well as active–low clock input.

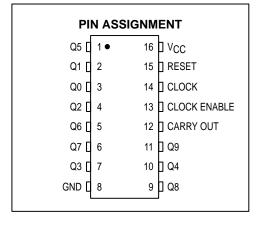
- Output Drive Capability: 10 LSTTL Loads
- Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 2 to 6 V
- Low Input Current: 1 μA
- High Noise Immunity Characteristic of CMOS Devices
- In Compliance with the Requirements Defined by JEDEC Standard No. 7A
- Chip Complexity: 176 FETs or 44 Equivalent Gates

LOGIC DIAGRAM



MC74HC4017







REV 6

10/95

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MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
VCC	DC Supply Voltage (Referenced to GND)	- 0.5 to + 7.0	V
V _{in}	DC Input Voltage (Referenced to GND)	- 1.5 to V _{CC} + 1.5	V
V _{out}	DC Output Voltage (Referenced to GND)	-0.5 to V _{CC} + 0.5	V
lin	DC Input Current, per Pin	± 20	mA
l _{out}	DC Output Current, per Pin	± 25	mA
ICC	DC Supply Current, V _{CC} and GND Pins	± 50	mA
PD	Power Dissipation in Still Air Plastic DIP† SOIC Package†	750 500	mW
T _{stg}	Storage Temperature	- 65 to + 150	°C
TL	Lead Temperature, 1 mm from Case for 10 Seconds (Plastic DIP or SOIC Package)	260	°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation, V_{in} and V_{out} should be constrained to the range GND \leq (V_{in} or V_{out}) \leq VCC. Unused inputs must always be tied to an appropriate logic voltage

level (e.g., either GND or V_{CC}). Unused outputs must be left open.

For high frequency or heavy load considerations, see Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit	
VCC	DC Supply Voltage (Referenced to GND)	2.0	6.0	V	
V _{in} , V _{out}	DC Input Voltage, Output Voltage (Refere	0	Vcc	V	
TA	Operating Temperature, All Package Type	- 55	+ 125	°C	
t _r , t _f	Input Rise and Fall Time (Figure 1)	V _{CC} = 2.0 V V _{CC} = 4.5 V V _{CC} = 6.0 V	0 0 0	1000 500 400	ns

DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

				Guaranteed Limit			
Symbol	Parameter	Test Conditions	v _{CC}	– 55 to 25°C	≤ 85 °C	≤ 125°C	Unit
VIH	Minimum High-Level Input Voltage	$V_{out} = 0.1 \text{ V or } V_{CC} - 0.1 \text{ V}$ $ I_{out} \le 20 \mu\text{A}$	2.0 4.5 6.0	1.5 3.15 4.2	1.5 3.15 4.2	1.5 3.15 4.2	V
VIL	Maximum Low–Level Input Voltage	$V_{Out} = 0.1 \text{ V or } V_{CC} - 0.1 \text{ V}$ $ I_{Out} \le 20 \mu\text{A}$	2.0 4.5 6.0	0.3 0.9 1.2	0.3 0.9 1.2	0.3 0.9 1.2	V
VOH	Minimum High-Level Output Voltage	$V_{in} = V_{IH} \text{ or } V_{IL}$ $ I_{out} \le 20 \mu\text{A}$	2.0 4.5 6.0	1.9 4.4 5.9	1.9 4.4 5.9	1.9 4.4 5.9	V
		$V_{\text{in}} = V_{\text{IH}} \text{ or } V_{\text{IL}} I_{\text{out}} \le 4.0 \text{ mA} I_{\text{out}} \le 5.2 \text{ mA}$	4.5 6.0	3.98 5.48	3.84 5.34	3.70 5.20	
VOL	Maximum Low–Level Output Voltage	$V_{in} = V_{IH} \text{ or } V_{IL}$ $ I_{out} \le 20 \mu\text{A}$	2.0 4.5 6.0	0.1 0.1 0.1	0.1 0.1 0.1	0.1 0.1 0.1	V
		$V_{\text{in}} = V_{\text{IH}} \text{ or } V_{\text{IL}} I_{\text{out}} \le 4.0 \text{ mA}$ $ I_{\text{out}} \le 5.2 \text{ mA}$	4.5 6.0	0.26 0.26	0.33 0.33	0.40 0.40	
l _{in}	Maximum Input Leakage Current	V _{in} = V _{CC} or GND	6.0	± 0.1	± 1.0	± 1.0	μΑ
lcc	Maximum Quiescent Supply Current (per Package)	$V_{in} = V_{CC}$ or GND $I_{out} = 0 \mu A$	6.0	8	80	160	μΑ

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

^{*} Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

[†]Derating — Plastic DIP: – 10 mW/°C from 65° to 125°C

SOIC Package: - 7 mW/°C from 65° to 125°C

AC ELECTRICAL CHARACTERISTICS ($C_L = 50 \text{ pF}$, Input $t_f = t_f = 6 \text{ ns}$)

			Gu	Guaranteed Limit		
Symbol	Parameter	V _{CC}	– 55 to 25°C	≤ 85°C	≤ 125°C	Unit
f _{max}	Maximum Clock Frequency (50% Duty Cycle) (Figures 1 and 9)	2.0 4.5 6.0	4.0 20 24	3.2 16 19	2.6 13 15	MHz
tPLH, tPHL	Maximum Propagation Delay, Clock to Q (Figures 1 and 9)	2.0 4.5 6.0	230 46 39	290 58 49	345 69 59	ns
tPLH, tPHL	Maximum Propagation Delay, Clock to Carry Out (Figures 2 and 9)	2.0 4.5 6.0	230 46 39	290 58 49	345 69 59	ns
tPLH, tPHL	Maximum Propagation Delay, Reset to Q (Figures 3 and 9)	2.0 4.5 6.0	230 46 39	290 58 49	345 69 59	ns
[†] PLH	Maximum Propagation Delay, Reset to Carry Out (Figures 3 and 9)	2.0 4.5 6.0	230 46 39	290 58 49	345 69 59	ns
tPLH, tPHL	Maximum Propagation Delay, Clock Enable to Q (Figures 4 and 9)	2.0 4.5 6.0	250 50 43	315 63 54	375 75 64	ns
tPLH, tPHL	Maximum Propagation Delay, Clock Enable to Carry Out (Figures 5 and 9)	2.0 4.5 6.0	250 50 43	315 63 54	375 75 64	ns
tTLH, tTHL	Maximum Output Transition Time, Any Output (Figures 8 and 9)	2.0 4.5 6.0	75 15 13	95 19 16	110 22 19	ns
C _{in}	Maximum Input Capacitance		10	10	10	pF

NOTES:

- 1. For propagation delays with loads other than 50 pF, see Chapter 2 of the Motorola High–Speed CMOS Data Book (DL129/D).
- 2. Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

		Typical @ 25°C, $V_{CC} = 5.0 \text{ V}$	
C _{PD}	Power Dissipation Capacitance (Per Package)*	35	pF

^{*} Used to determine the no–load dynamic power consumption: P_D = C_{PD} V_{CC}²f + I_{CC} V_{CC}. For load considerations, see Chapter 2 of the Motorola High–Speed CMOS Data Book (DL129/D).

3

TIMING REQUIREMENTS (Input $t_r = t_f = 6$ ns)t

			Guaranteed Limit			
Symbol	Parameter	V _{CC}	– 55 to 25°C	≤ 85°C	≤ 125°C	Unit
t _{Su}	Minimum Setup Time, Clock Enable to Clock (Figure 6)	2.0 4.5 6.0	50 10 9	65 13 11	75 15 13	ns
t _{su}	Minimum Setup Time, Clock Enable to Clock (Inhibit Count) (Figure 6)	2.0 4.5 6.0	50 10 9	65 13 11	75 15 13	ns
^t h	Minimum Hold Time, Clock to Clock Enable (Figure 6)	2.0 4.5 6.0	50 10 9	65 13 11	75 15 13	ns
t _{rec}	Minimum Recovery Time, Reset to Clock (Figure 7)	2.0 4.5 6.0	100 20 17	125 25 21	150 30 26	ns
t _w	Minimum Pulse Width, Clock Input (Figure 2)	2.0 4.5 6.0	80 16 14	100 20 17	120 24 20	ns
t _W	Minimum Pulse Width, Reset Input (Figure 3)	2.0 4.5 6.0	80 16 14	100 20 17	120 24 20	ns
t _W	Minimum Pulse Width, Clock Enable Input (Figure 4)	2.0 4.5 6.0	80 16 14	100 20 17	120 24 20	ns
t _r , t _f	Maximum Input Rise and Fall Times (Figure 1)	2.0 4.5 6.0	1000 500 400	1000 500 400	1000 500 400	ns

NOTE: Information on typical parametric values can be found in Chapter 2 of the Motorola High-Speed CMOS Data Book (DL129/D).

FUNCTION TABLE

Clock	Clock Enable	Reset	Output State*
L	Х	L	no change
Х	Н	L	no change
Х	Χ	Н	reset counter, Q0 = H, Q1-Q9 = L, C0 = H
	L	L	advance to next state
_	Χ	L	no change
Х		L	no change
Н	~	L	advance to next state

X = Don't care

PIN DESCRIPTIONS

INPUTS

Clock (Pin 14)

Counter clock input. While Clock Enable is low, a low-to-high transition on this input advances the counter to its next state.

Reset (Pin 15)

Asynchronous counter reset input. A high level at this input initializes the counter and forces Q0 and Carry Out to a high, Q1–Q9 are forced to a low level.

Clock Enable (Pin 13)

Active—low clock enable input. A low level on this input allows the device to count. A high level on this input inhibits the counting operation. This input may also be used as a

negative-edge clock input. using Clock (Pin 14) as an active-high enable pin.

OUTPUTS

Q0-Q9 (Pins 3, 2, 4, 7, 10, 1, 5, 6, 9, 11)

Decoded decade counter outputs. Each of these outputs is high for one clock period only.

Carry Out (Pin 12)

Cascading output pin. This output is used either as a cascading output or a symmetrical divide—by—ten output. This output goes low when a count of five is reached and high when the counter advances to zero or when reset. When the counters are cascaded this output provides a rising—edge signal for the clock input of the next counter stage.

^{*} Carry Out = H for Q0, Q1, Q2, Q3, or Q4 = H; Carry Out = L otherwise.

SWITCHING WAVEFORMS

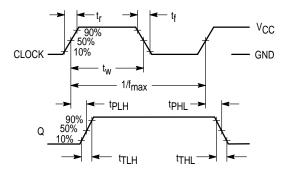


Figure 1.

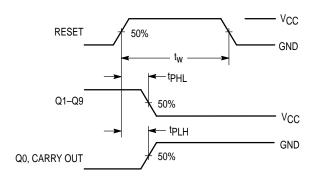


Figure 3.

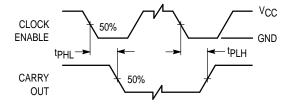


Figure 5.

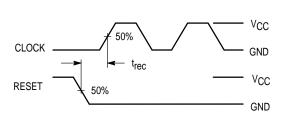


Figure 7.

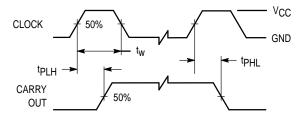


Figure 2.

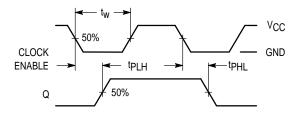


Figure 4.

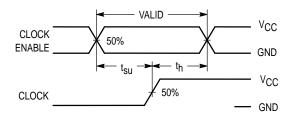


Figure 6.

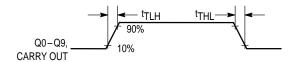
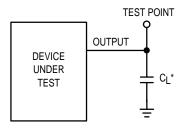


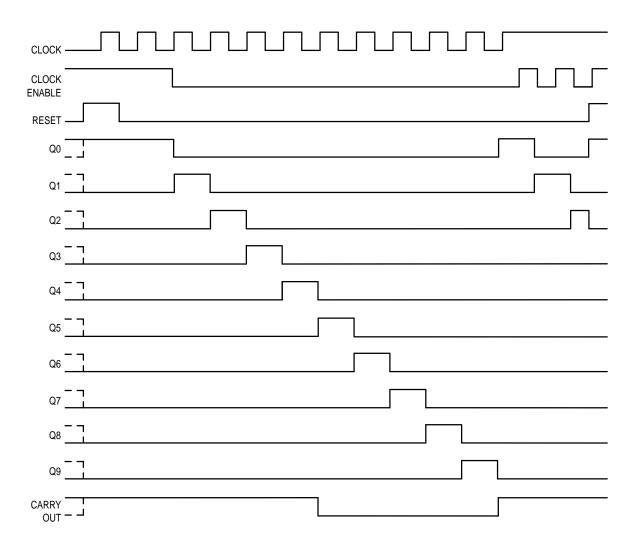
Figure 8.



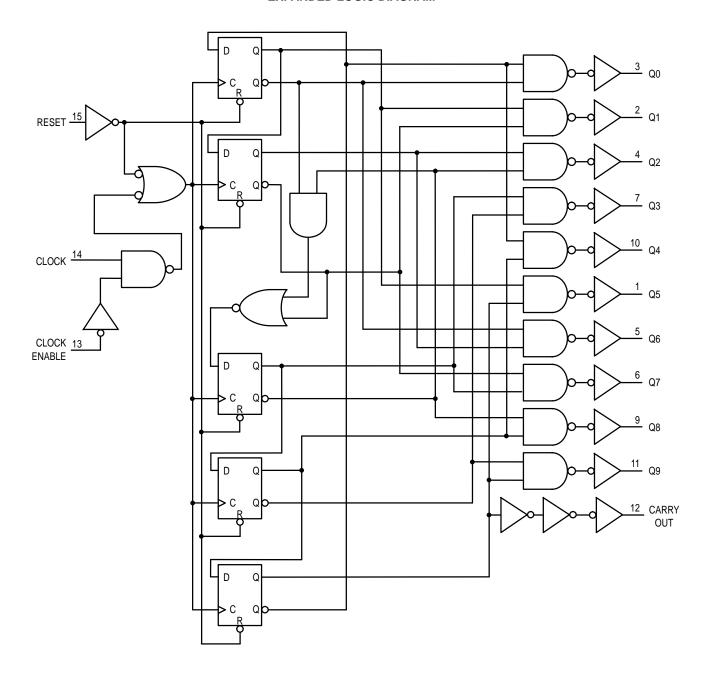
* Includes all probe and jig capacitance

Figure 9. Test Circuit

TIMIING DIAGRAM



EXPANDED LOGIC DIAGRAM



TYPICAL APPLICATIONS

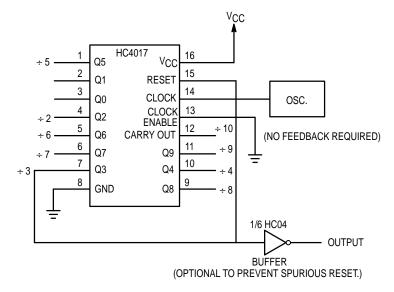


Figure 10 shows a divide by 2 through 10 circuit using one HC4017. Please note that since Reset is asynchronous, the output pulse widths are narrow.

Figure 10. ÷2 Through ÷ 10 Circuit

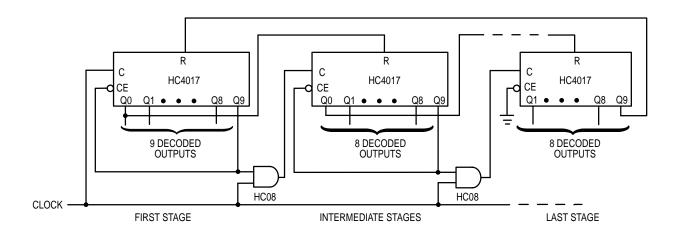
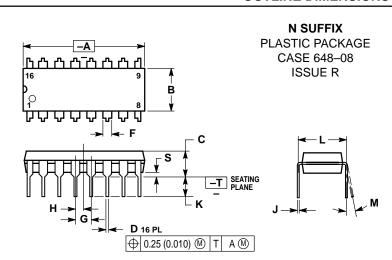


Figure 11 shows a technique for cascading the counters to extend the number of decoded output states. Decoded outputs are sequential within each stage and from stage to stage, with no dead time (except propagation delay).

Figure 11. Counter Expansion

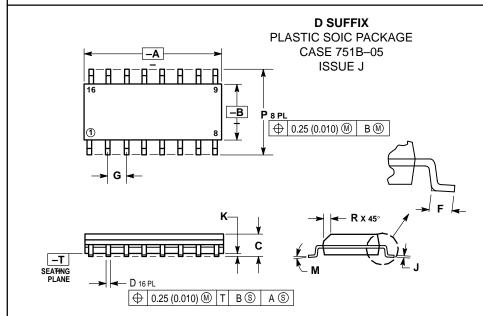
OUTLINE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
- CONTROLLING DIMENSION: INCH.
 DIMENSION L TO CENTER OF LEADS WHEN
 FORMED PARALLEL.
- DIMENSION B DOES NOT INCLUDE MOLD FLASH.
- ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
С	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.070	1.02	1.77	
G	0.	100 BSC	2.54 BSC		
Н	0.	050 BSC	1	.27 BSC	
J	0.008	0.015	0.21	0.38	
K	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
M	0°	10°	0°	10°	
S	0.020	0.040	0.51	1.01	



NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
- DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIM	MILLIMETERS		HES
DIM	MIN	MAX	MIN	MAX
Α	9.80	10.00	0.386	0.393
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.2	1.27 BSC) BSC
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
Р	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

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MC74HC4017/D